SN74LV74A-Q1 DUAL POSITIVE-EDGE-TRIGGERED D-TYPE FLIP-FLOP

SCLS556B - DECEMBER 2003 - REVISED APRIL 2008

- Qualified for Automotive Applications
- 2-V to 5.5-V V_{CC} Operation
- Max t_{pd} of 13 ns at 5 V
- Typical V_{OLP} (Output Ground Bounce)
 <0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot)
 >2.3 V at V_{CC} = 3.3 V, T_A = 25°C
- Support Mixed-Mode Voltage Operation on All Ports
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

(TOP VIEW) 1CLR 14 🛮 V_{CC} 1D [13 2CLR 1CLK II 3 12 7 2D 1PRE 4 11 ¶ 2CLK 10 1 2PRE 1Q [[1Q [6 9 2Q 8 2Q GND [

D OR PW PACKAGE

description/ordering informationS

This dual positive-edge-triggered D-type flip-flop is designed for 2-V to 5.5-V V_{CC} operation.

A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are inactive (high), data at the data (D) inputs meeting the setup-time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDERING INFORMATION[†]

T _A	PACKAGE‡		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 125°C	SOIC - D	Tape and reel	SN74LV74AQDRQ1	LV74A
-40 C to 125°C	TSSOP - PW	Tape and reel	SN74LV74AQPWRQ1	LV74A

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



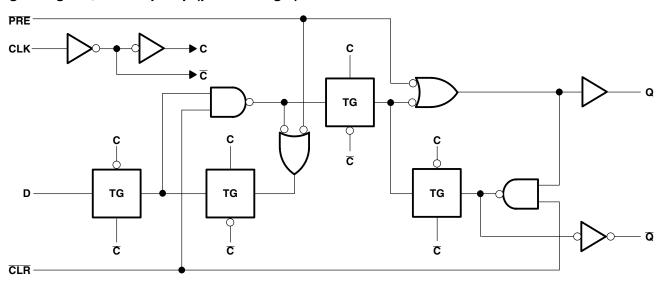
[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

FUNCTION TABLE

	INP	UTS		OUTI	PUTS
PRE	CLR	CLK	D	Q	Q
L	Н	Х	Χ	Н	L
Н	L	X	Χ	L	Н
L	L	Х	Χ	H [†]	H [†]
Н	Н	\uparrow	Н	Н	L
Н	Н	\uparrow	L	L	Н
Н	Н	L	Χ	Q_0	\overline{Q}_0

[†] This configuration is nonstable; that is, it does not persist when PRE or CLR returns to its inactive (high) level.

logic diagram, each flip-flop (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high-impe	dance
or power-off state, V _O (see Note 1)	–0.5 V to 7 V
Output voltage range, V _O (see Notes 1 and 2)	–0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$)	–20 mA
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ_{JA} (see Note 3): D p	ackage 86°C/W
PW	package 113°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 5.5 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51-7.



recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
V_{CC}	Supply voltage		2	5.5	V
		V _{CC} = 2 V	1.5		
.,	Little Level Secretarion	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	$V_{CC} \times 0.7$		٧
V_{IH}	High-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	$V_{CC} \times 0.7$		V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	$V_{CC} \times 0.7$		
		V _{CC} = 2 V		0.5	
.,	Land to a literatura to a the ma	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$	V
V_{IL}	Low-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		$V_{CC} \times 0.3$	V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		$V_{CC} \times 0.3$	
V_{I}	Input voltage		0	5.5	٧
Vo	Output voltage		0	V_{CC}	V
		V _{CC} = 2 V		-50	μΑ
	High lavel autout august	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-2	
l _{OH}	High-level output current	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		-6	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		-12	
		V _{CC} = 2 V		50	μΑ
	Land to the set of the	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2	
l _{OL}	Low-level output current	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		6	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		12	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		200	
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		100	ns/V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		20	
T _A	Operating free-air temperature		-40	125	°C

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT		
	$I_{OH} = -50 \mu\text{A}$	2 V to 5.5 V	V _{CC} -0.1					
l _v	$I_{OH} = -2 \text{ mA}$	2.3 V	2			٧		
V _{OH}	$I_{OH} = -6 \text{ mA}$	3 V	2.48			V		
	I _{OH} = -12 mA	4.5 V	3.8					
	$I_{OL} = 50 \mu A$	2 V to 5.5 V			0.1			
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	I _{OL} = 2 mA	2.3 V			0.4	0.44 V		
V _{OL}	I _{OL} = 6 mA	3 V			0.44			
	I _{OL} = 12 mA	4.5 V			0.55			
I _I	V _I = 5.5 V or GND	0 to 5.5 V			±1	μΑ		
I _{CC}	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			20	μΑ		
I _{off}	V_I or $V_O = 0$ to 5.5 V	0			5	μΑ		
C	V _I = V _{CC} or GND	3.3 V		2		pF		
C _i	AI = ACC OL GIAD	5 V		2		þΓ		

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timing requirements over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted) (see Figure 1)

	DADAMETED		$T_A = 2$	25°C		MAY		
	PARAMETER		MIN	MAX	MIN	MAX	UNIT	
	Pulse densities	PRE or CLR low	8		9			
t _w	Pulse duration CLK				9		ns	
	Oaton time hafers OLIVA	Data	8		9			
t _{su}	Setup time before CLK↑	PRE or CLR inactive	7		7		ns	
t _h	t _h Hold time, data after CLK↑				0.5		ns	

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

	DADAMETED		T _A = 2	25°C	MIN		
	PARAMETER		MIN	MAX	MIN	MAX	UNIT
	t _w Pulse duration	PRE or CLR low	6		7		
τ _w		CLK	6		7		ns
		Data	6		7		
t _{su} Setup ti	Setup time before CLK↑	PRE or CLR inactive	5		5		ns
t _h	Hold time, data after CLK↑		0.5		0.5		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

	24244555		T _A = 2	25°C				
	PARAMETER		MIN	MAX	MIN	MAX	UNIT	
	t _w Pulse duration	PRE or CLR low	5		5			
τ _W		CLK	5		5		ns	
		Data	5		5			
t _{su} Setup time before CLK	Setup time before CLK↑	PRE or CLR inactive			3		ns	
t _h	Hold time, data after CLK↑		0.5		0.5		ns	

switching characteristics over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	_	LOAD	T _A = 25°C			MIN	MAX	LINUT
	(INPUT)		CAPACITANCE	MIN	TYP	MAX	IVIIN	WAX	UNIT
f _{max}			$C_L = 50 pF$	30	70		25		MHz
t _{pd}	PRE or CLR	Q or $\overline{\mathbb{Q}}$	C		13	17.4	1	20	
	CLK	QorQ	$C_L = 50 \text{ pF}$		14.2	20	1	23	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			MAINI	MAX	UNIT
				MIN	TYP	MAX	MIN	IVIAA	UNIT
f _{max}			C _L = 50 pF	50	90		45		MHz
	PRE or CLR	Q or Q	C _L = 50 pF		9.2	15.8	1	18	no
^t pd	CLK				10.2	15.4	1	18	ns



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	то	LOAD CAPACITANCE	T _A = 25°C			MINI	MAY	LINUT
		(OUTPUT)		MIN	TYP	MAX	MIN	MAX	UNIT
f _{max}			C _L = 50 pF	90	140		75		MHz
t _{pd}	PRE or CLR	Q or Q	C _L = 50 pF		6.6	9.7	1	12	ns ns
	CLK				7.2	9.3	1	13	

noise characteristics, $V_{CC} = 3.3 \text{ V}$, $C_L = 50 \text{ pF}$, $T_A = 25^{\circ}\text{C}$ (see Note 5)

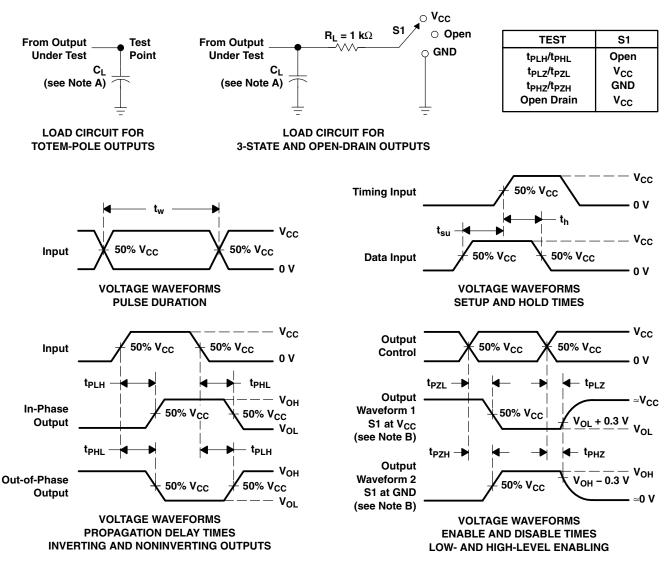
	PARAMETER	MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.1	8.0	V
$V_{OL(V)}$	Quiet output, minimum dynamic V _{OL}		0	-0.8	V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}		3.2		V
$V_{IH(D)}$	High-level dynamic input voltage	2.31			V
$V_{IL(D)}$	Low-level dynamic input voltage			0.99	V

NOTE 5: Characteristics are for surface-mount packages only.

operating characteristics, $T_A = 25^{\circ}C$

PARAMETER			TEST CONDITIONS			UNIT
	Power dissination consistence	C - 50 nE	f = 10 MHz	3.3 V	21	PF
C _{pd}	Power dissipation capacitance	$C_L = 50 \text{ pF},$	I = IO WIHZ	5 V	23	pr

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f \leq 3$ ns. $t_f \leq 3$ ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en}.
- G. t_{PHL} and t_{PLH} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



6-Jan-2013

PACKAGING INFORMATION

Orderable Device		Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Samples
	(1)					(2)		(-)	(Requires Login)
SN74LV74AQDRG4Q1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74LV74AQDRQ1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74LV74AQPWRG4Q1	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74LV74AQPWRQ1 C	DBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74LV74A-Q1:





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● Enhanced Product: SN74LV74A-EP

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
 - Sody length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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